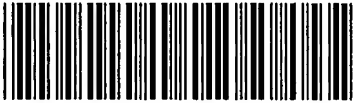


**Search Notes**

Application/Control No.

10/564,332

Examiner

Megann E. Vaughn

Applicant(s)/Patent under  
Reexamination

KAWANISHI ET AL.

Art Unit

2859

**SEARCHED**

Class	Subclass	Date	Examiner
374	45	8/16/2007	MV
73	61.46	8/16/2007	MV
123	406.12	8/16/2007	MV

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
see attached EAST Search History	8/16/2007	MV